

Notice of References Cited

Application/Control No.

09/987.660

Applicant(s)/Patent Under

Reexamination

IYETCHIKA ET AL.

Examiner

Long K. Tran

Art Unit

2818

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,023,077	02-2000	Iyechika et al.	257/103
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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